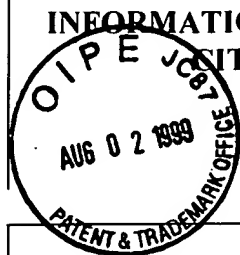


Atty. Docket No.: D-43025-01

Serial No.: 09/268,892

INFORMATION DISCLOSURE  
CITATION

Applicant(s): Hatfield

Filing Date: March 16, 1999

Group: \*2878

## U.S. PATENT DOCUMENTS

Examiner Initials		Document Number	Date	Name	Class	Sub Class	Filing Date If Appropriate
len	1.	3,063,010	11/06/62	Richardson	325	364	04/25/60
len	2.	3,673,107	06/27/72	Peters	252	408	12/18/69
len	3.	4,668,714	05/26/87	Morita et al	523	136	08/29/85
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		Document Number	Date	Country	Class	Sub Class	Translation
							Yes No
len	1.	1 303 278	01/17/73	FR	1	1	1999
len	2.	2 402 681	04/06/79	FR	1	1	
len	3.	1-169387	07/04/89	JP	1	1	X

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len	1.	ESR study of free radicals created by irradiation in some organic substances. (Nucl. Sci. Abstr. 1970, 24(17))
	2.	Mixed-Field dosimetry in a cyclotron-produced fast neutron radiotherapy beam with special emphasis on a newly developed alanine system (Inst. Nucl. Phys., Krakow, Pol.)
	3.	Free radical dosimetry by chemical readout (Div. Radiol. Prot., Bhabha At. Res. Cent., Bombay, 400 085 India).
	4.	Thin Film Alanine-Polyethylene dosimeter (Appl. Radiat. Isot. 44, 1993) pp. 41-45.
	5.	Alanine Dosimeters Using polymers as Binders (Appl. Radiat. Isot. 37, No. 6) pp. 517-520 - 1986
	6.	Dosimetry by ESR Spectroscopy of Alanine (Appl. Radiat. Isot. 33) pp. 1101-1114 - 1982
len	7.	Use of Glucose Solutions in Cobalt-60 Gamma Ray Dosimetry (Int. Journal of Applied Radiation....) Vol. 21 pp.143-146

EXAMINER

len. NGUYEN

Date Considered

04-11-01

\*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

# INFORMATION DISCLOSURE CITATION

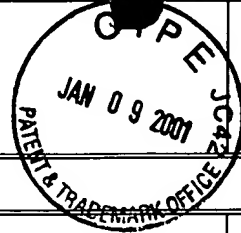
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Group: \*



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EN	1.	5,451,505	09/19/95	Dollinger	—	—	

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							Yes	No
EN	1.	94/16902	08/04/94	WO	—	—		

## OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)


EXAMINER

K. NGUYEN

Date Considered

04-11-07

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